TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62593AFN,TD62594AFN,TD62597AFN,TD62598AFN

8CH SINGLE DRIVER : COMMON EMITTER

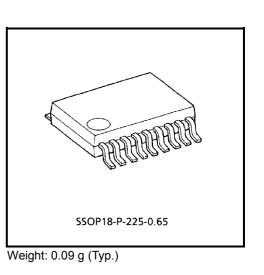
The TD62593, 4, 7, 8AFN are comprised of eight NPN Transistor Arrays.

Applications include relay, hammer, lamp and display (LED) drivers.

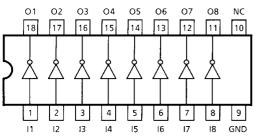
FEATURES

- Package Type : SSOP18pin (0.65 mm pitch)
- High Sustaining Voltage Output : 50 V (MIN)
- Low Saturation Voltage : V_{CE} (sat) = 0.8 V @IOUT = 150 mA·Inputs Compatible with Various type Logic. TD62593AFN, TD62597AFN : R_{IN} = 2.7 k Ω TTL, 5 V CMOS TD62594AFN, TD62598AFN : R_{IN} = 10.5 k Ω 6~15 V PMOS, CMOS

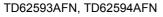
PIN CONNECTION (TOP VIEW)

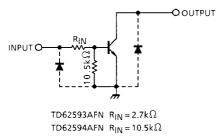


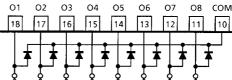




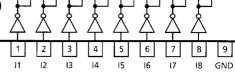
SCHEMATICS (EACH DRIVER)



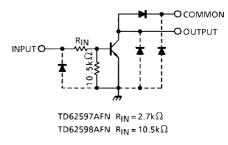


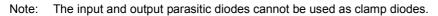


TD62597AFN, TD62598AFN



TD62597AFN, TD62598AFN





MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Collector-Emitter Voltage	V _{CEO}	50	V	
Collector-Base Voltage	V _{CBO}	50	V	
Clamp Diode Reverse Voltage	V _R (Note 1)	50	V	
Collector Current	Ι _C	200	mA / ch	
Input Voltage	V _{IN}	-0.5~30	V	
Power Dissipation	P _D (Note 2)	0.96	W	
Operating Temperature	T _{opr}	-40~85	°C	
Storage Temperature	T _{stg}	-55~150	°C	

Note 1: Except TD62593AFN, TD62594AFN

Note 2: On Glass Epoxy PCB (50 × 50 ×1.6 mm Cu 40%)

RECOMMENDED OPERATING CONDITIONS (Ta = -40~85°C)

CHARACTERISTIC		SYMBOL	CONDITION	MIN	TYP.	MAX	UNIT
Collector-Emitter Voltage		V _{CEO}		0	_	50	V
Collector-Base Volt	age	V _{CBO}		0	_	50	V
Collector Current		ΙC		0	_	150	mA / ch
Clamp Diode Reverse Voltage		V _R (Note 1)		7	_	50	V
Input Voltage		V _{IN}		0	_	25	V
Input Current	nput Current			0	_	10	mA
Input Voltage (Output On)	TD62593AFN TD62597AFN	– V _{IN (ON)}		2.4	_	25	v
	TD62594AFN TD62598AFN			7.0	_	25	
Power Dissipation		P _D (Note 2)		_	—	0.4	W

Note 1: Except TD62593AFN, TD62594AFN

Note 2: On Glass Epoxy PCB (50 × 50 × 1.6 mm Cu 40%)

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

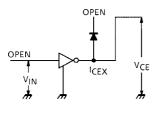
CHARA	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT
Output Leakage	Current	ICEX	1	V _{CE} = 50 V, V _{IN} = 0	_	_	10	μA
Output Saturation Voltage		V _{CE (sat)}	2	I _C = 10 mA, I _{IN} = 0.4 mA	—	—	0.2	v
				I _C = 150 mA, I _{IN} = 3.0 mA	—	—	0.8	
DC Current Trans	sfer Ratio	h _{FE}	2	V _{CE} = 10 V, I _C = 10 mA	50	_	_	
Input Current	TD62593AFN TD62597AFN	lu com	3	V _{IN} = 2.4 V, I _C = 50 mA	_	_	0.9	mA
	TD62594AFN TD62598AFN	IIN (ON)		V _{IN} = 7.0 V, I _C = 50 mA	_	_	0.9	ШA
Turn−On Delay		t _{ON}	4	V _{OUT} = 50 V, R _L = 330 Ω	_	0.1	_	
Turn-Off Delay		tOFF	4	VOUT - 30 V, NL - 330 W	_	3.0	_	μs

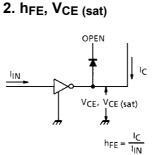
TOSHIBA

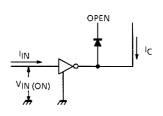
3. IIN (ON)

TEST CIRCUIT

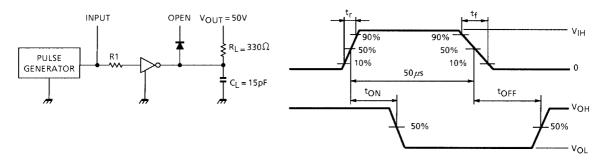








4. ton, toff



Note 1: Pulse Width 50 μ s, Duty Cycle 10% Output Impedance 50 Ω , t_r ≤ 5 ns, t_f ≤ 10 ns Note 2: See below

Input Condition

TYPE NUMBER	R _{IN}	V _{IH}
TD62593AFN, TD62597AFN	0 Ω	3 V
TD62594AFN, TD62598AFN	0 Ω	10 V

Note 3: CL includes probe and jig capacitance

PRECAUTIONS for USING

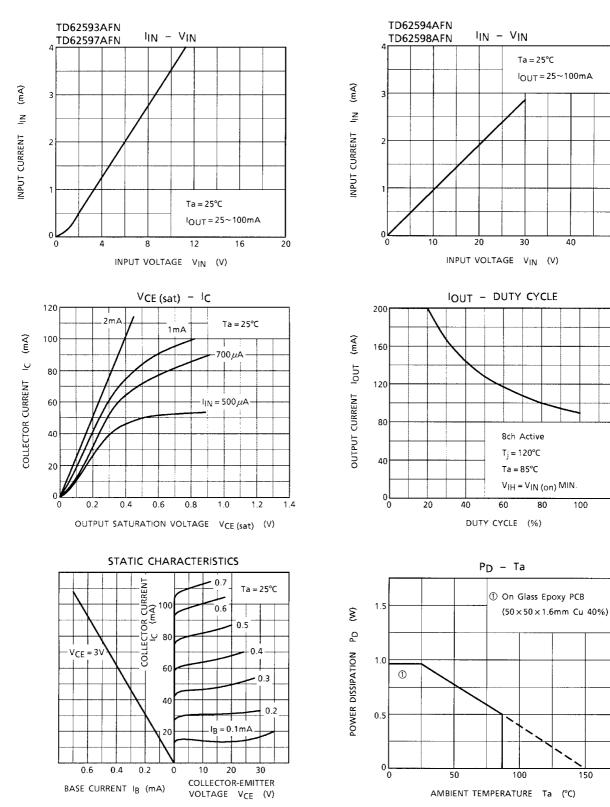
This IC does not integrate protection circuits such as overcurrent and overvoltage protectors.

Thus, if excess current or voltage is applied to the IC, the IC may be damaged. Please design the IC so that excess current or voltage will not be applied to the IC.

Utmost care is necessary in the design of the output line, V_{CC} and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

TOSHIBA

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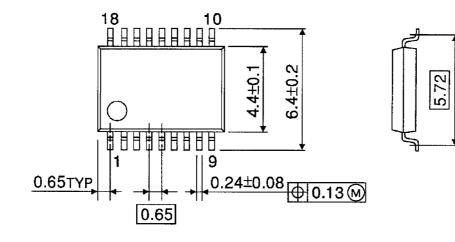
TOSHIBA

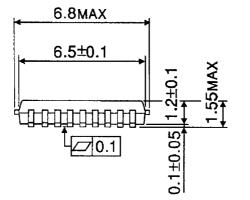
(225mil)

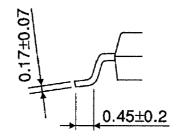
PACKAGE DIMENSIONS

SSOP18-P-225-0.65

Unit: mm







Weight: 0.09 g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

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